Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,674	CHOI ET AL.	
Examiner	Art Unit	
RICARDO L. OSORIO	2629	

SEARCHED			
Class	Subclass	Date	Examiner
345	63,77,89, 102,204, 690	7/7/2006	RLO
_			
		•	
	-	•	
		-	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
,			

SEAR (INCLUDING S	CH NOTES EARCH STR	ATEGY)	
	С	DATE	EXMR
east	7/1	7/2006	RLO